

Notice of References Cited	Application/Control No. 10/644,859	Applicant(s)/Patent Under Reexamination KAKIUCHI ET AL.	
	Examiner Chen-Wen Jiang	Art Unit 3744	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0130652 A1	06-2006	Takewaki et al.	095/148
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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